

X-Ray Diffraction Use for PZN-PT Single Crystal's Synthesis and Microscopic Thermal Dilatation Coefficient Determination

Diouma KOBOR¹, Laurent LEBRUN² and Daniel GUYOMAR²

1: ICPM, Université Assane Seck de Ziguinchor, BP 523, Ziguinchor, Sénégal, dkobor@univ-zig.sn

2: LGEF, INSA de Lyon, Bâtiment Gustave Ferrié, 8 rue de la Physique, 69621 Villeurbanne Cedex, France, laurent.lebrun@insa-lyon.fr

Introduction:

The performance of transducers can be significantly increased by the use of active materials with large piezoelectric coefficients (d_{ij}) and large coupling factors (k_{ij}) [1]. Recently, high levels of piezoelectricity have been published in $\text{Pb}(\text{Mg}_{1/3}\text{Nb}_{2/3})\text{O}_3\text{-PbTiO}_3$ (PMN-PT) and $\text{Pb}(\text{Zn}_{1/3}\text{Nb}_{2/3})\text{O}_3\text{-PbTiO}_3$ (PZN-PT) single crystals: $d_{33} > 2500 \text{ pC/N}$, $d_{31} > -1500 \text{ pC/N}$, $k_{33} > 90\%$, $k_{31} > 80\%$ and $k_t > 60\%$ [1-5].

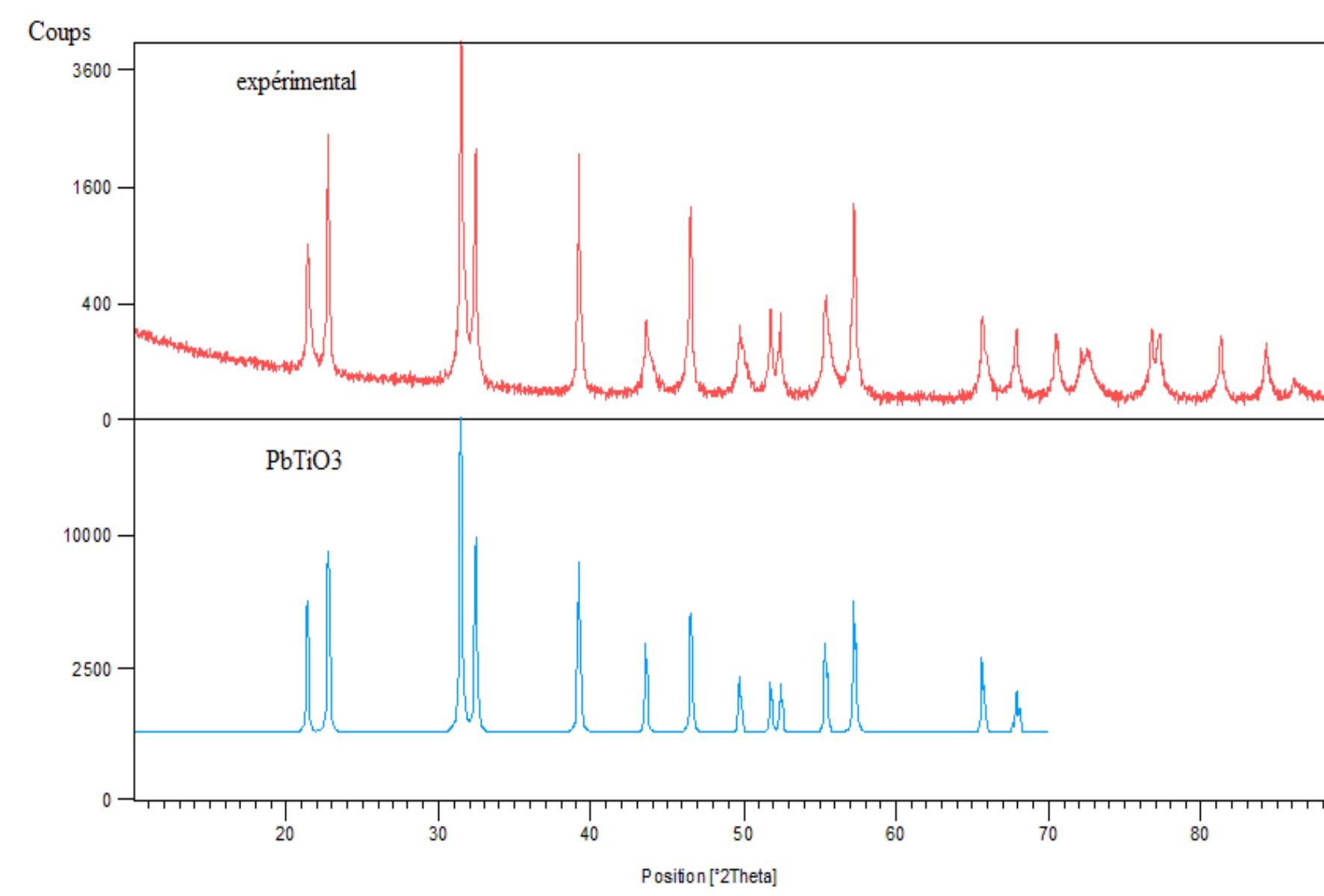
X-Ray Diffraction is an excellent technique to follow and analyze structures and crystallographic phases of solid materials.

In this paper we use the X-Ray powder Diffraction technique for controlling the different steps PZN-4.5PT single crystals synthesis and its thermal characterization.

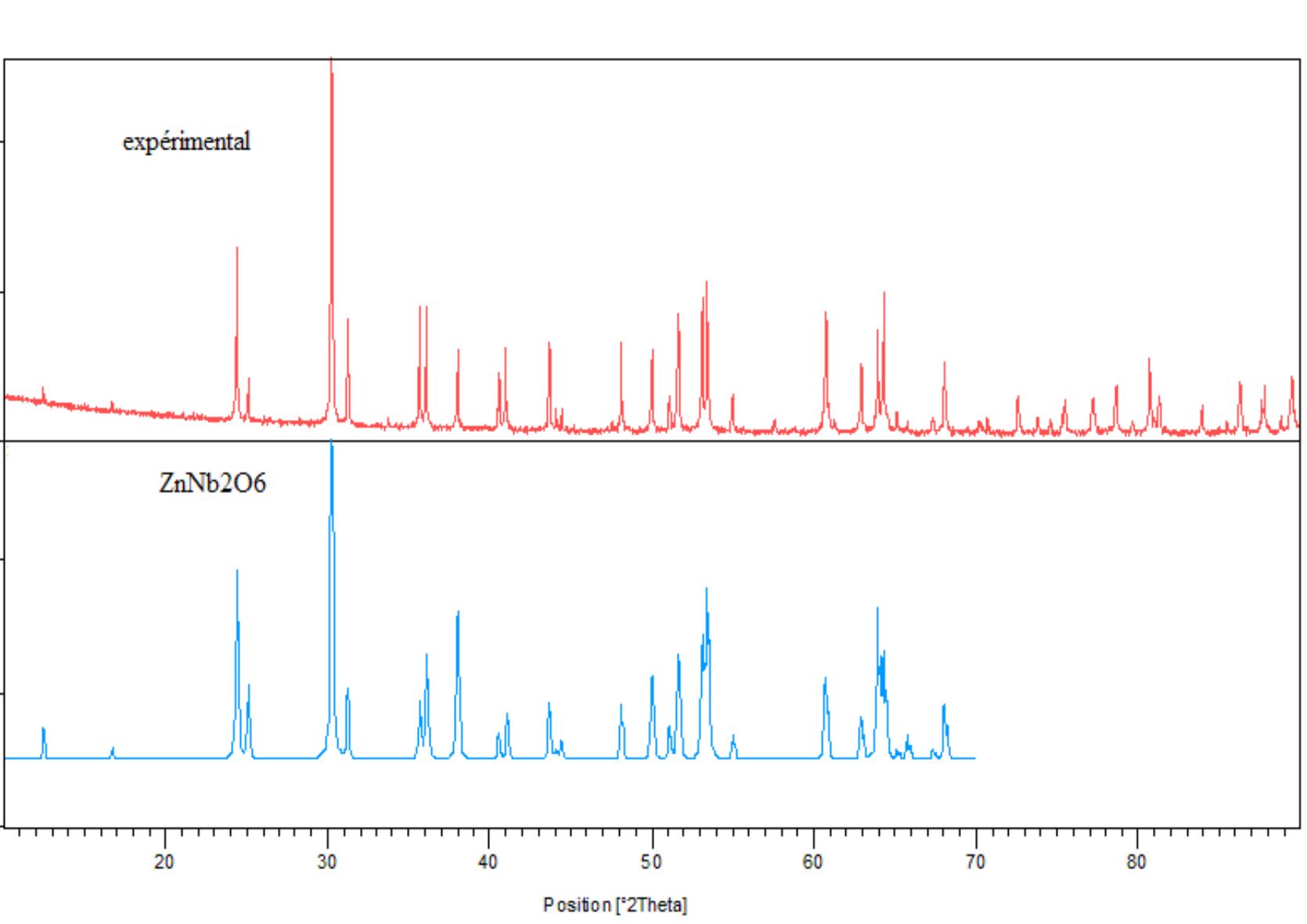
Furnace used for growth of PZN-4.5PT single crystals by Flux method



X-Ray Powder Diffraction of PbTiO_3 precursor

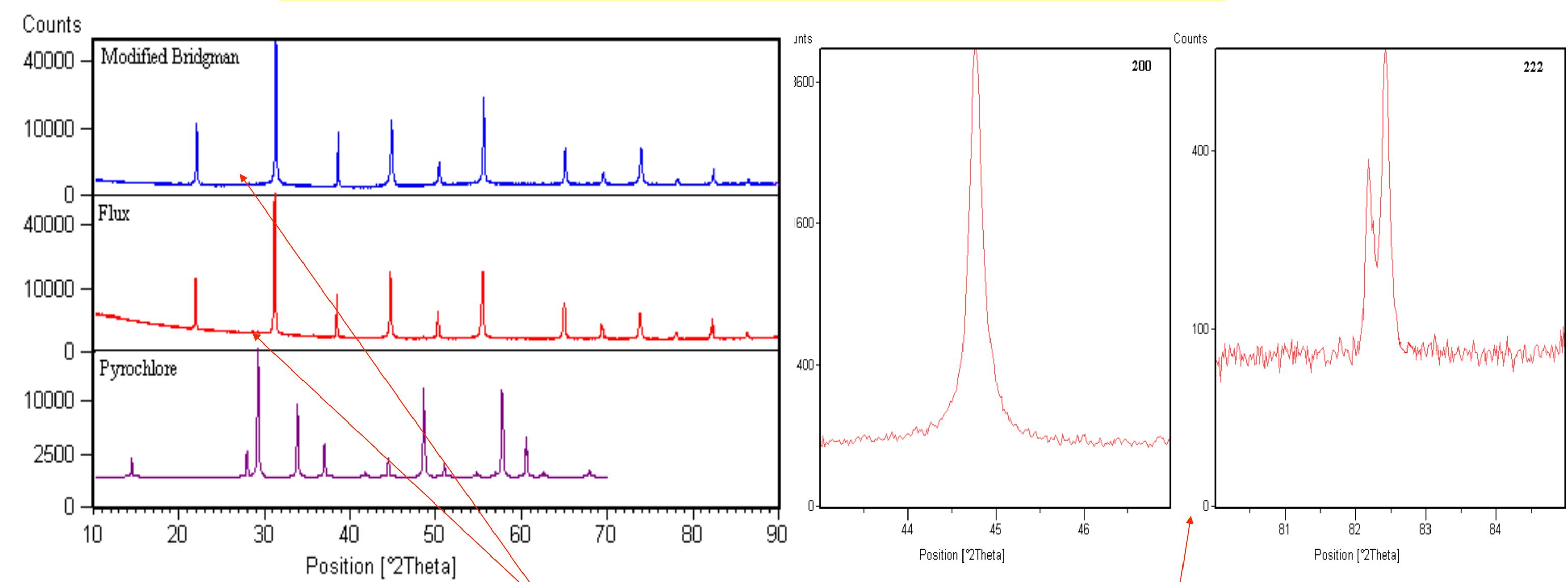


X-Ray Powder Diffraction of ZnNb_2O_6 precursor



The experimental and the bibliographical spectra present the same peaks at the same angles

X-ray powder diffraction patterns of as grown crystals



By Flux method

By Modified Bridgman method

no pyrochlore phase is detected

Rhombohedral symmetry in ambient temperature

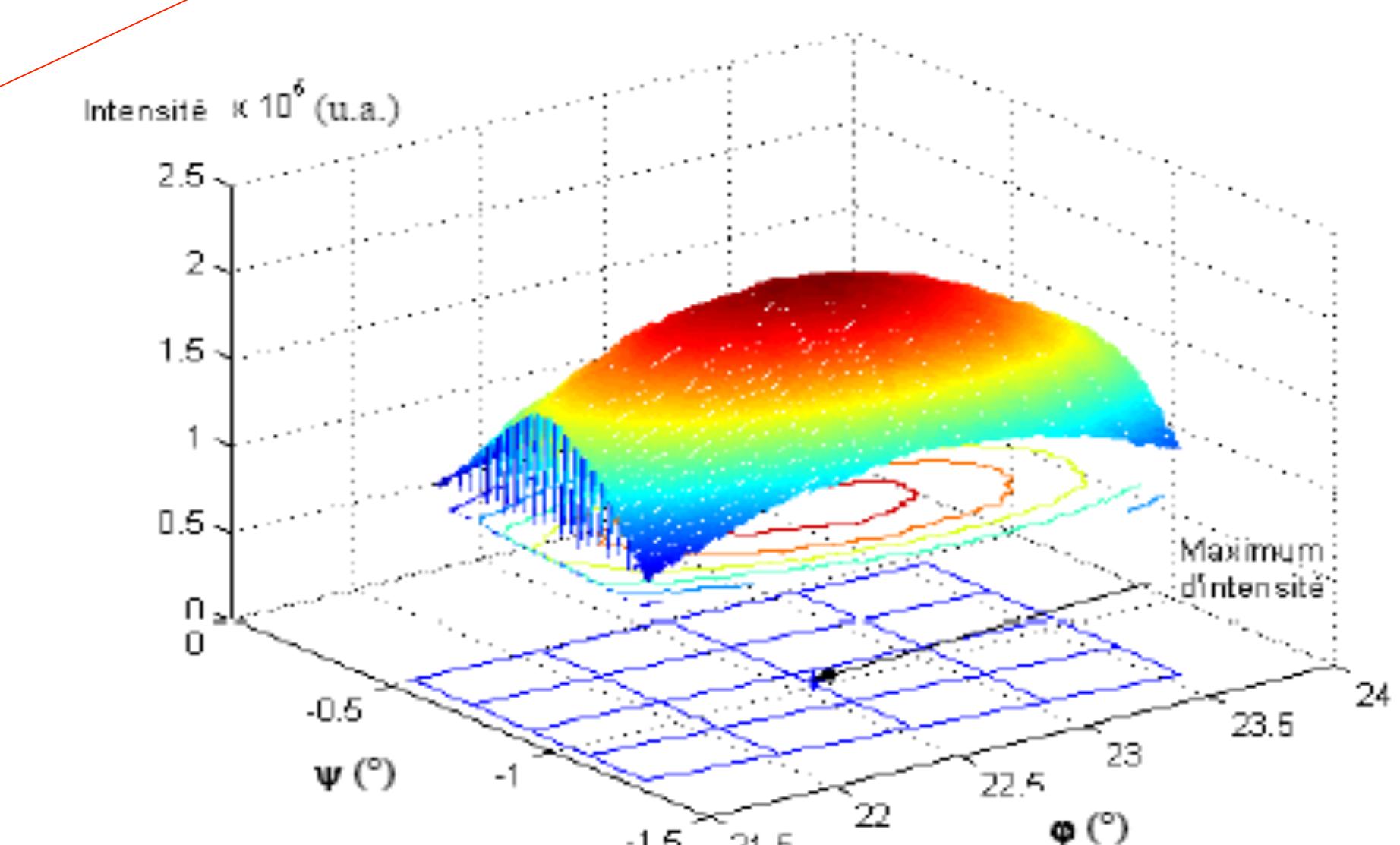
Table 1: Lattice parameters at T ambient and T = 300°C

Parameters	Rhombohedral (ambient temperature)		Cubic (300 °C)	
	modified Bridgman	Flux method	modified Bridgman	Flux method
$a = b = c (\text{\AA})$	4.054(5)	4.054(2)	4.0595(6)	4.0592(9)
$\alpha = \beta = \gamma (\text{ }^\circ)$	89.9318	89.8694	90	90
$V (\text{\AA}^3)$	66.6756	66.6376	66.902	66.884

Table 2: XRD theoretical peaks for different crystal system types

Crystal System	Cell parameters	Types of spectra		
		h00	hh0	hh0
Cubic	$a=b=c, \alpha=\beta=\gamma=90^\circ$	h00	hh0	hh0
Tetragonal	$a=b \neq c, \alpha=\beta=\gamma=90^\circ$	00h, 0h0	hh0	hh0, h0h
Rhombohedral	$a=b=c, \alpha=\beta=\gamma \neq 90^\circ$	hh0	hhh, -hhh	hh0, -hh0
Orthorhombic, P	$a \neq b \neq c, \alpha=\beta=\gamma=90^\circ$	00h, h00, 0h0	hh0	h0h, Ohh, hh0
Orthorhombic, B	$a \neq b \neq c, \alpha=\beta=\gamma \neq 90^\circ$	h0h, 0h0	0h2h, 2hh0	002h, 2h0h, hh0
Monoclinic	$a \neq b \neq c, \alpha=\gamma=90^\circ, \beta > 90^\circ$	00h, h00, 0h0	hh-h, hhh	h0-h, h0h, Ohh, hh0

The single crystals orientation using the XRD source of X'Pertpro of Panalytical



An example of figures of poles obtained on PZN-4.5PT single crystals

The calcul of the thermal dilatation coefficient by XRD (microscopic) and TMA (macroscopic): the values are slight the same for the two methods

Samples/ $\alpha_a (10^{-6} \text{ }^\circ\text{C}^{-1})$	XRD method	TMA method
PZN-4.5PT	5	-
PZN-4.5PT+1%Mn	8	9.4
PZN-4.5PT+2%Mn	10	9.8

Acknowledgments :

This work is supported by DGA (Délégation Générale pour l'Armement)

REFERENCES

- [1] : S. Zhang, L. Lebrun, S. Liu, S. Rhee, C. A. Randall, T. R. Shrout, Jpn. J. Appl. Phys. 41 (2002)
- [2] : K. Harada, Y. Hosono, , S. Saitoh, Y. Yamashita. J. Appl. Phys 39 (2000) 3117
- [3] : M. L. Mulvihill, S. E. Park, G. Risch, Z. Li, K. Uchino, T. R. Shrout, Jpn. J. Appl. Phys. 35
- [4] : M. Dong, Z. G. Ye, J. Appl. Phys. 40 (2001) 4604
- [5] : D. Kobor, L. Lebrun, G. Sébald, and D. Guyomar, J. Crystal growth, 275 (2005) 580.

XRD diagrams: the bragg peaks 200 and 222 at different temperatures. permit to determine the different phases transitions (rhombohedral to tetragonal (ambient – 150 °C) and from tetragonal to cubic (150 °C- 200 °C) considering table 2) and to calculate the thermal dilatation coefficient at microscopic scale

Conclusion :

PZN-4.5PT single crystals have been grown by the flux method. The use of X-Ray powder diffraction permitted us to determine the different changes of structure at different temperatures and for the crystal orientation.

The main innovation is the use of this technique to calculate the thermal dilatation coefficient by the lattice parameters variation versus temperature and the comparison of the microscopic and macroscopic values.